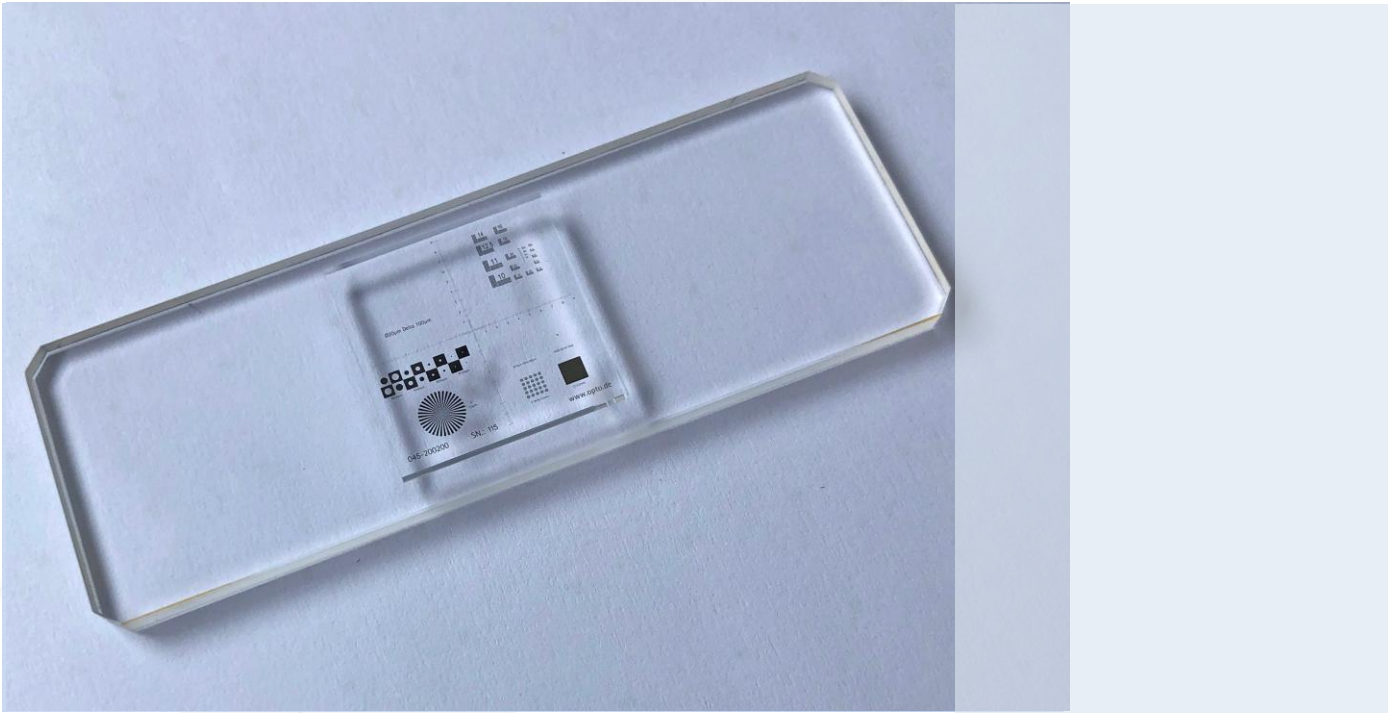


## Calibration Target Micro V2 with Resolution Test 1000 LP/mm

High resolution micro-imaging pattern



### High Class Imaging Technology at Opto

Optical calibration and resolution testing are critical metrics in understanding and optimizing any optical system.

The **Calibration Target Micro V2** stands out for combining extremely useful resolution data with ultra-high-resolution microstructures. Together, these features enable the efficient and precise optimisation of any optical setup.

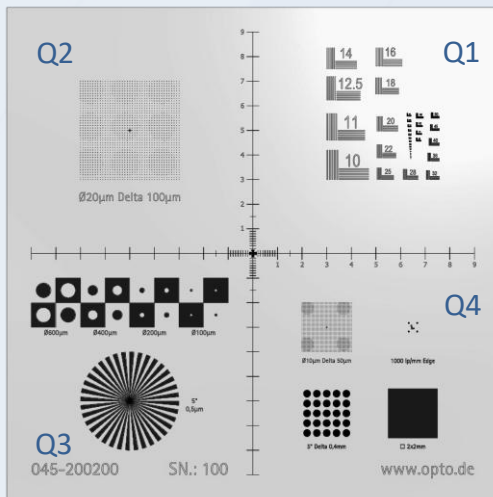
- ultra-high-definition micro features, compatible to the most demanding optical calibration requirements
- four unique quadrants combining resolution targets to measurement scales
- supplied in a dedicated padded storage case



## Technical Features

Item number	045-200200
Structure*	high reflective chrome on glass
Minimal structure size	0.5 $\mu\text{m}$
Maximal structure size	600 $\mu\text{m}$
Structure shapes	various shapes
Scale	in x- and y-direction with an accuracy of +/- 0.5 $\mu\text{m}$
Dimension	76 x 26 x 4.5 mm
Weight	17 g
DAkKS-certification (accreditation in accordance with DIN EN ISO/IEC17025) available on request	

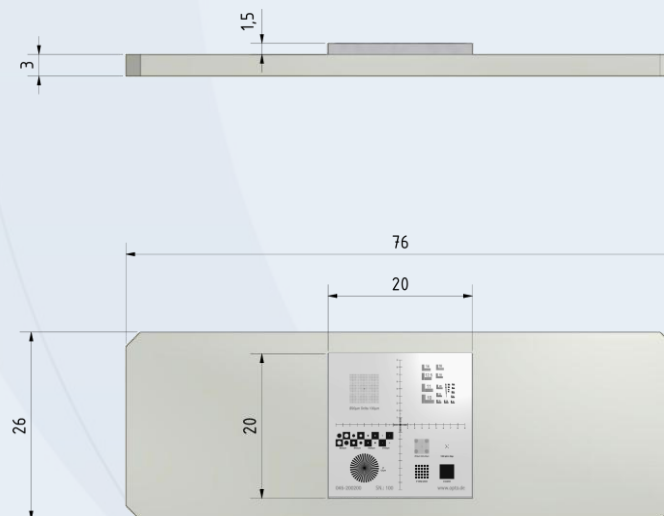
\*Particles can remain at small structures on the mask due to the manufacturing process.



**Calibration Target Micro V2** contains defined structures in different shapes and sizes for easy system calibration and distortion detection.

- Q1 10 lp/mm to 1000 lp/mm (1100 lp/mm as bonus, not specified)
- Q2 matrix 40 x 40 dots  $\varnothing$  20  $\mu\text{m}$ , 100  $\mu\text{m}$  grid
- Q3 positive, negative dots, Siemens star and serial number structure
- Q4 matrix 40 x 40 dots  $\varnothing$  10  $\mu\text{m}$ , 50  $\mu\text{m}$  grid  
10° edge in center of 4x line pair matrix (1000 lp/mm)  
5x5 Siemens star matrix, 0.4 mm grid  
2x2 mm full chrome square
- Scale in x- and y-direction with an accuracy +/- 0,5 $\mu\text{m}$

## Technical Drawing



04/2026 - Specifications are subject to change without prior notice.